

**Index of Claims**

**Application/Control No.**

10/047,717

**Applicant(s)/Patent under Reexamination**

KNAPP, RICHARD J.

**Examiner**

Tan Dean D. Nguyen

**Art Unit**

3629

✓	<b>Rejected</b>
=	<b>Allowed</b>

-	(Through numeral) Cancelled
+	<b>Restricted</b>

N	<b>Non-Elected</b>
I	<b>Interference</b>

A	<b>Appeal</b>
O	<b>Objected</b>

Claim	Date
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Claim	Date
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